

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/750.567	MCALPINE ET AL.		
Examiner	Art Unit		
Yaima Campos	2185		

Yaima Campos

SEARCHED					
Class	Subclass	Date	Examine		
	+				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examine		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EIC PLUS search	6/5/2006	YC		
PALM and EAST inventor name search	6/5/2006	YC		
Text search within subclasses 711/203-209,221	6/5/2006	YC		